



12/17/04

IFW '1744

PATENT
Attorney Docket No.: 1332/US/1
Express Mail Label No.: EV 423776544 US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Applicant	: Cacka et al.	
Appln. No.	: 10/045,953	Confirmation No.: 2740
Filed	: January 12, 2002	Group Art Unit: 1744
Title	: TOOTHBRUSH	Examiner: Not Yet Assigned

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Commissioner for Patents
P.O. Box 1450
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Sir:

The undersigned hereby certifies that the following documents:

1. Supplemental Information Disclosure Statement (2 pages);
2. Form PTO-1449 (5 pages);
3. Copies of One Hundred and Seventy-five (175) References;
4. Certificate of Mailing by Express Mail (1 page); and
5. Return Card

relating to the above application, were deposited as "Express Mail" under 37 CFR § 1.10, Mailing Label No. EV 423776544 US, with the United States Postal Service addressed to Mail Stop Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on December 16, 2004.



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Title	:	TOOTHBRUSH	Examiner: Till, Terrence R.

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER
37 C.F.R. §§1.97(b)(4) and 1.98**

MAIL STOP AMENDMENT
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Sir:

The Examiner is requested to consider the references noted on the enclosed Form PTO-1449 during examination of the above-identified patent application. These references are submitted for the Examiner's consideration and are submitted pursuant to the duty of disclosure under 37 C.F.R. § 1.56. In submitting these references, no representation is made or implied that the references are or are not material to the examination of the application. The Examiner is encouraged to make his or her own determination of materiality. Copies of all the cited art documents are provided herewith.

This IDS is being filed before the first Office action, after the filing of a Request for Continued Examination. Accordingly, pursuant to 37 C.F.R. § 1.97(b)(4), no fees are due with respect to this filing. However, should any such fees or petitions be required, please consider this a request therefor and authorization to charge Deposit Account No. 04-1415 as necessary.

PATENT

Attorney Docket No. 1332/US/1
Express Mail Label No. EV 423776544 US

Should the Examiner have any questions, please contact the undersigned attorney.

Dated: 16 December 2004.

Respectfully submitted,


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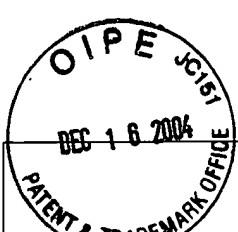
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT: Cacka et al.	
		FILING DATE January 12, 2002	ART UNIT 1744

DEC 16 2004

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PATENT & TRADEMARK OFFICE

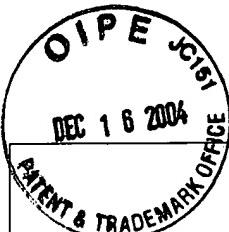
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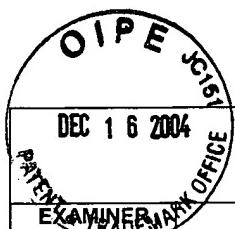
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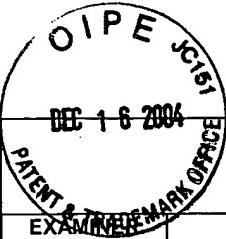
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FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

EXAMINER INITIAL		DOCUMENT NUMBER	PUBLISHED DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES
							NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		